

100V N-Channel Power MOSFET

DESCRIPTION

The IRLR3410TR uses advanced trench technology to provide excellent RDS(ON), low gate charge. It can be used in a wide variety of applications.

Application

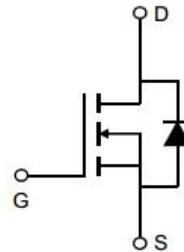
- ① Power switching application
- ② Hard switched and High frequency circuits
- ③ Uninterruptible power supply

KEY CHARACTERISTICS

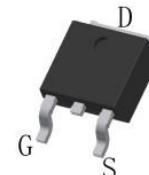
- ① $V_{DS} = 100V, I_D = 13A$
 $R_{DS(ON)} < 120m\Omega @ V_{GS}=10V$
- ② High density cell design for lower $R_{DS(on)}$
- ③ Fully characterized avalanche voltage and current
- ④ Good stability and uniformity with high EAS
- ⑤ Excellent package for good heat dissipation

100% UIS TESTED !

100% DVDS TESTED !



Schematic diagram



TO-252

Package Marking And Ordering Information

Ordering Codes	Package	Product Code	Packing
IRLR3410TR	TO-252	IRLR3410TR	Reel

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	100	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	13	A
Drain Current-Pulsed (Note 1)	I_{DM}	40	A
Maximum Power Dissipation($T_c=25^\circ C$)	P_D	31	W
Single pulse avalanche energy(Note 2)	EAS	21	mJ
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 175	°C

Thermal Characteristic

Thermal Resistance,Junction-to-Case	$R_{\theta JC}$	4.8	°C/W
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Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BVDSS	VGS=0V ID=250μA	100	-	-	V
Zero Gate Voltage Drain Current	IDSS	VDS=100V, VGS=0V	-	-	1	μA
Gate-Body Leakage Current	IGSS	VGS=±20V, VDS=0V	-	-	±100	nA
On Characteristics						
Gate Threshold Voltage	VGS(th)	VDS=VGS, ID=250μA	1	1.8	2.4	V
Drain-Source On-State Resistance ^(Note 3)	RDS(ON)	VGS=10V, ID=5A	-	110	120	mΩ
Forward Transconductance	gFS	VDS=25V, ID=3.6A	-	5	-	S
Dynamic Characteristics						
Input Capacitance	Ciss	VDS=25V, VGS=0V, f=1.0MHz	-	680	-	pF
Output Capacitance	Coss		-	110	-	pF
Reverse Transfer Capacitance	Crss		-	85	-	pF
Switching Characteristics (Note 4)						
Turn-on Delay Time	td(on)	VDD=50V, ID=5A, VGS=10V, RGEN=2.5Ω	-	10	-	nS
Turn-on Rise Time	tr		-	7	-	nS
Turn-Off Delay Time	td(off)		-	34	-	nS
Turn-Off Fall Time	tf		-	9	-	nS
Total Gate Charge	Qg	VDS=80V, ID=3A VGS=10V	-	16	-	nC
Gate-Source Charge	Qgs		-	4	-	nC
Gate-Drain Charge	Qgd		-	5	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage	VSD	VGS=0V, IS=15A	-	-	1.2	V

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. EAS condition : Tj=25°C, VDD=50V, VGS=10V, L=0.5mH, Rg=25Ω
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production.

Characteristics Curves

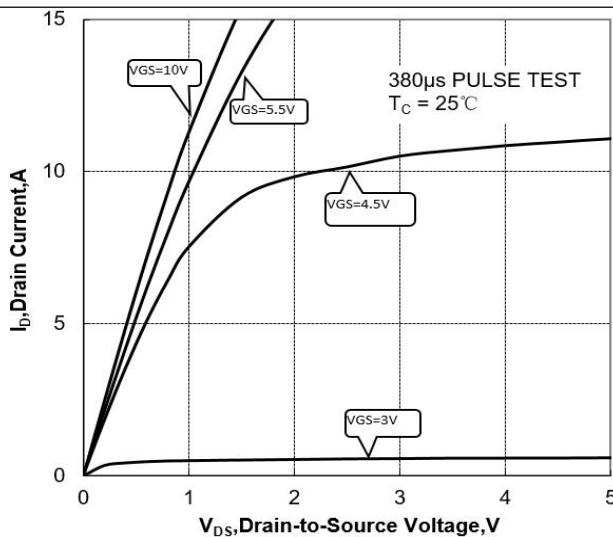
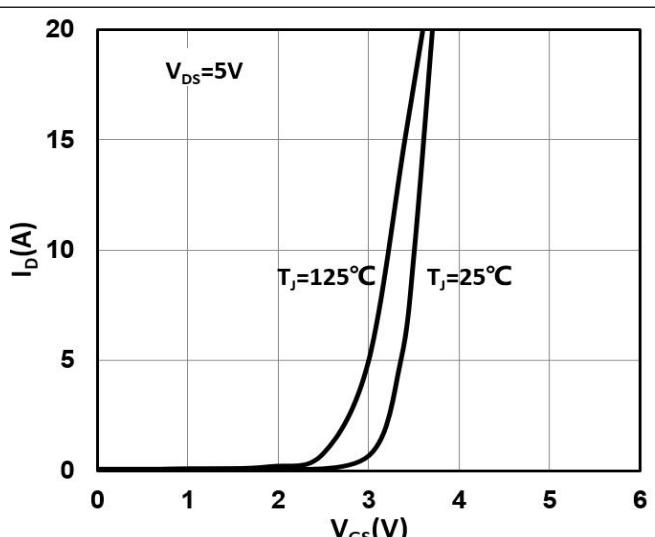
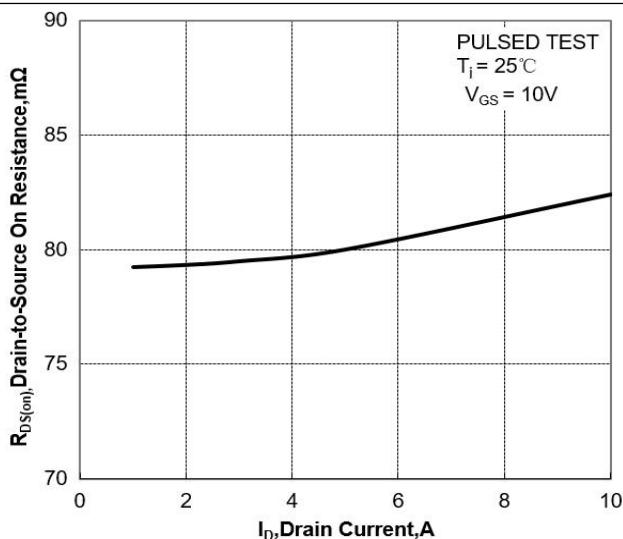
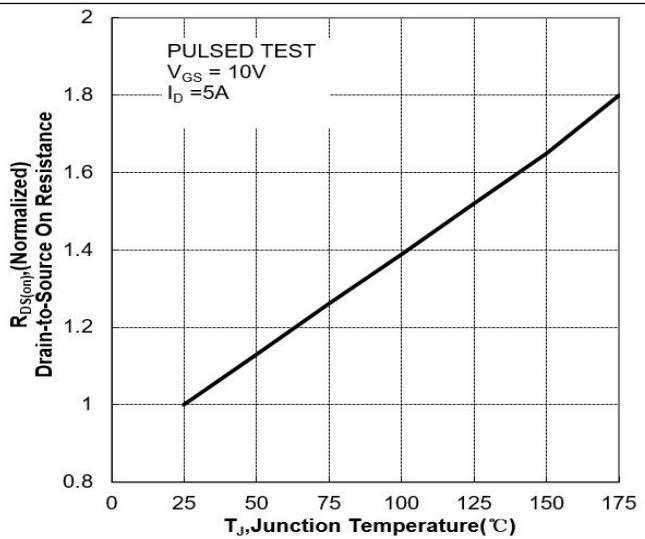
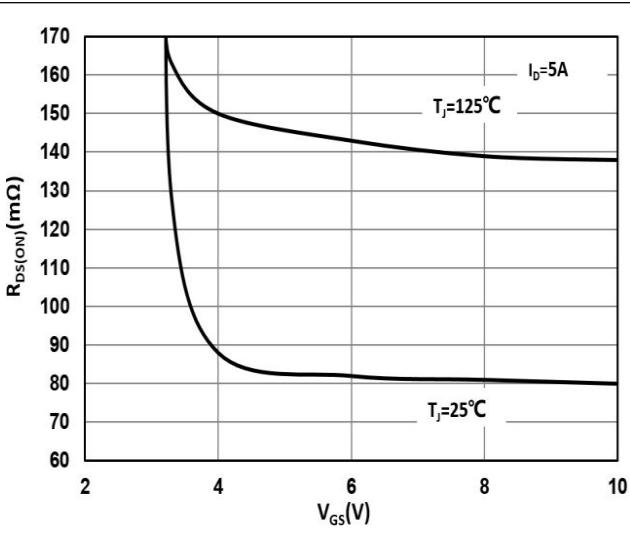
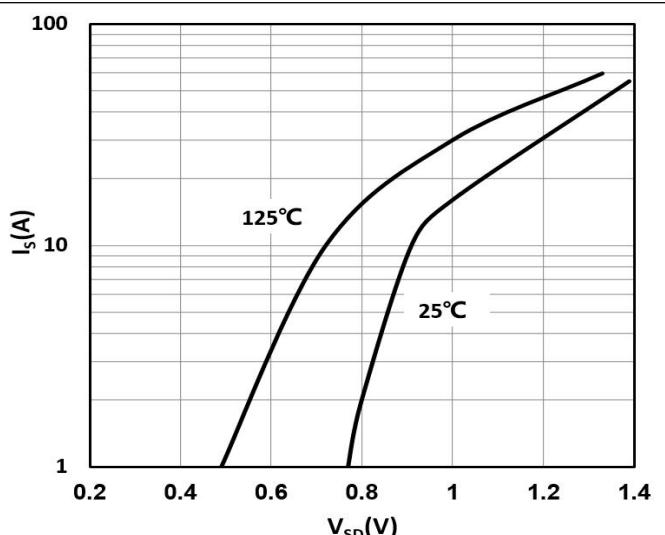
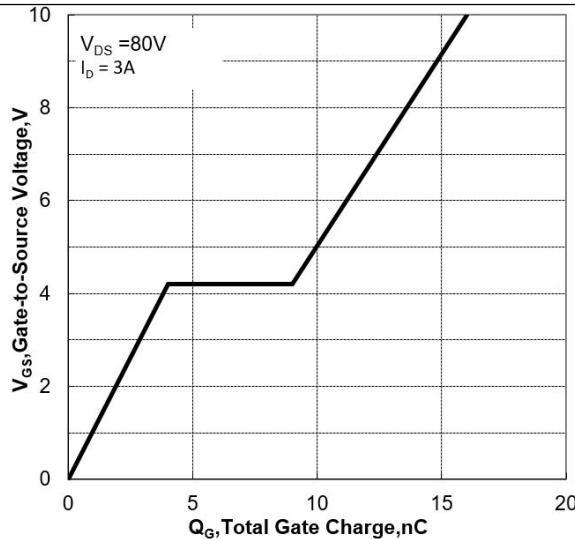
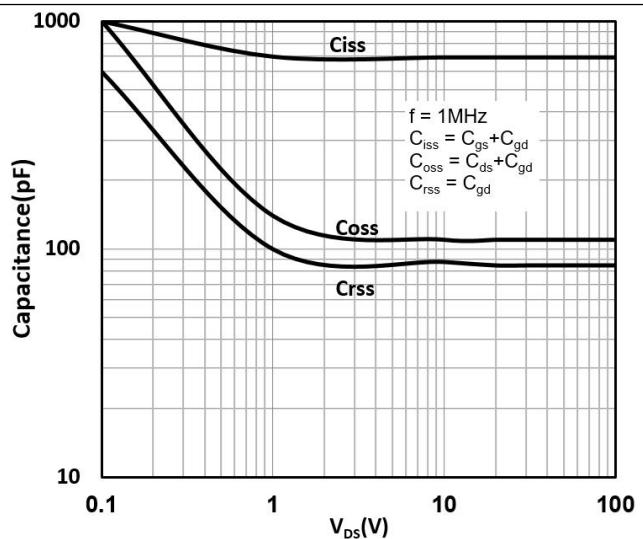
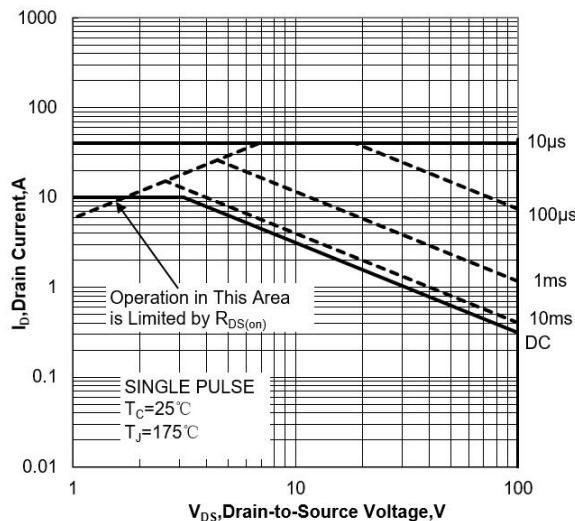
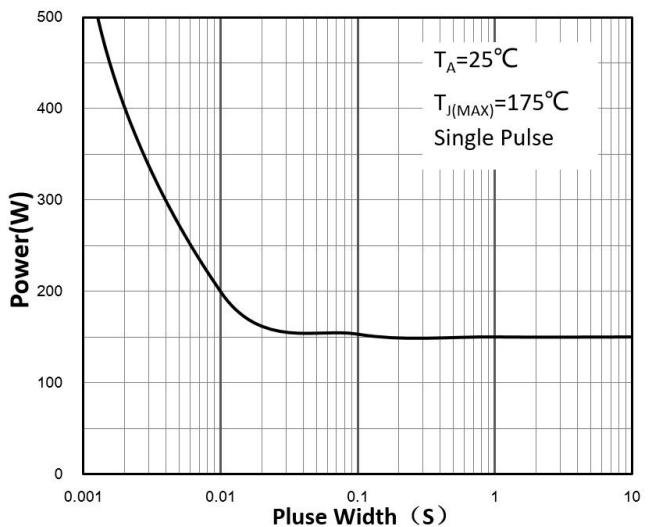
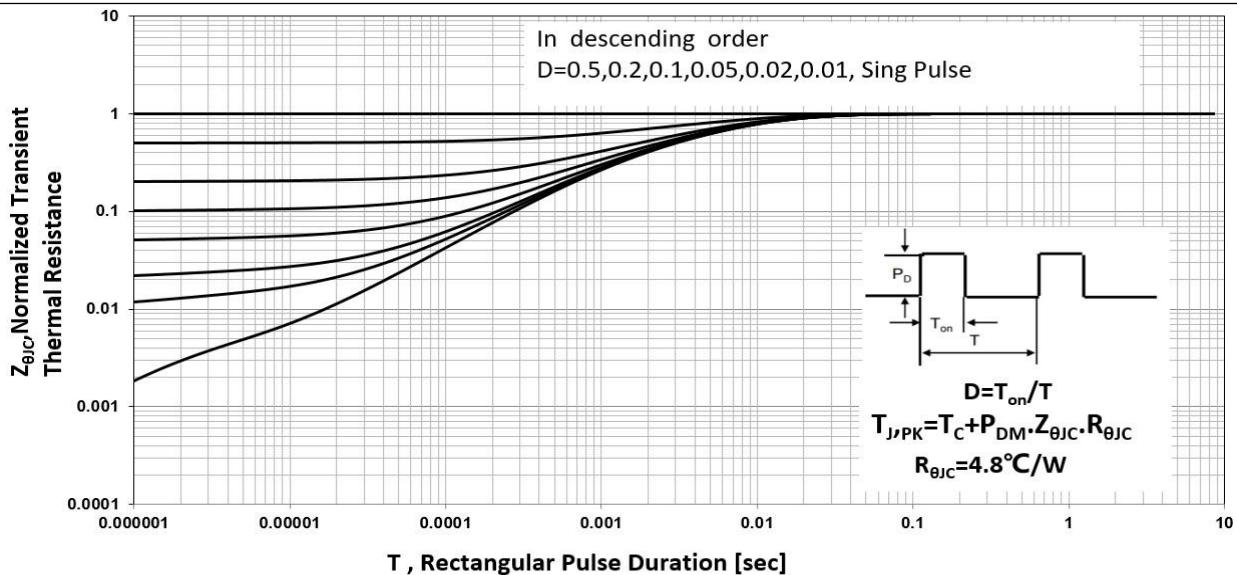
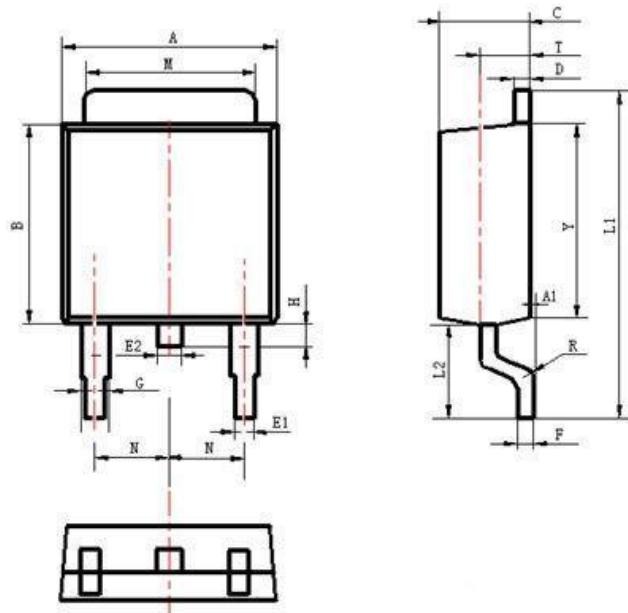
Figure 1 Output Characteristics

Figure 2 Transfer Characteristics

Figure 3 On-Resistance vs. ID and VGS

Figure 4 On-Resistance vs. Junction Temperature

Figure 5 On-Resistance vs. VGS

Figure 6 Body Diode Forward Voltage


Figure 7 Gate-Charge Characteristics

Figure 8 Capacitance Characteristics

Figure 9 Maximum Forward Biased Safe Operation Area

Figure 10 Single Pulse Power Rating Junction-to-Ambient

Figure 11 Normalized Maximum Transient Thermal Impedance


Test Circuit and Waveform

Gate Charge Test Circuit	Gate Charge Test Waveform
Resistive Switching Test Circuit	Resistive Switching Test Waveforms
Unclamped Inductive Switching (UIS) Test Circuit	Unclamped Inductive Switching (UIS) Test Waveforms
Diode Recovery Test Circuit	Diode Recovery Test Waveforms

Package Description



Items	Values(mm)	
	MIN	MAX
A	6.30	6.90
A1	0	0.13
B	5.70	6.30
C	2.10	2.50
D	0.30	0.60
E1	0.60	0.90
E2	0.70	1.00
F	0.30	0.60
G	0.70	1.20
L1	9.60	10.50
L2	2.70	3.10
H	0.60	1.00
M	5.10	5.50
N	2.09	2.49
R	0.3	
T	1.40	1.60
Y	5.10	6.30

TO-252 Package



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NOTE:

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
2. When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
3. MOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
4. Shenzhen Minos reserves the right to make changes in this specification sheet and is subject to change without prior notice.

CONTACT:

深圳市迈诺斯科技有限公司（总部）

地址：深圳市福田区华富街道田面社区深南中路4026号田面城市大厦22B-22C

邮编：518025

电话：0755-83273777